

Features

- · 3rd generation SiC MOSFET technology
- · Optimized package with separate driver source pin
- · High blocking voltage with low on-resistance
- · High-speed switching with low capacitances
- · Fast intrinsic diode with low reverse recovery (Q_{rr})
- · Halogen free, RoHS compliant

Benefits

- · Reduce switching losses and minimize gate ringing
- · Higher system effciency
- · Reduce cooling requirements
- · Increase power density
- · Increase system switching frequency

Applications

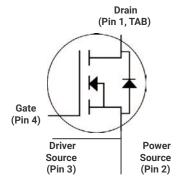
- · Renewable energy
- · EV battery chargers
- · High voltage DC/DC converters
- · Switch Mode Power Supplies

Ordering Part Number	Package	Qty(PCS)
C2M0040065K	TO-247-4L (TO-247-4)	30





TO-247-4L (TO-247-4)



Maximum Ratings (Tc = 25 °C unless otherwise specifed)

Parameter	Symbol	Value	Unit
Drain-source voltage	V _{DS}	650	V
Continuous drain current Tc = 25°C Tc = 100°C	lo	49 53	А
Pulsed drain current (Tc = 25°C, tp limited by T _{jmax})	ID pulse	123	Α
Avalanche energy, single pulse (L=10mH)	Eas	1000	mJ
Gate-Source voltage	Vgs	-5/+20	V
Gate-Source voltage (dynamic,Absolute maximum values)	VGSmax	-10/+25	V
Power dissipation (Tc = 25°C)	Ptot	242	W
Operating junction and storage temperature	T _j , T _{stg}	-55+175	°C

Thermal Resistance

Parameter	Symbol	Value	Unit	
Thermal resistance, junction – case. Max	RthJC	0.62	°C/W	
Thermal resistance, junction – ambient. Max	RthJA	40		



Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition	
rai ailletei	Syllibol	min.	typ.	max.	Offic	rest Condition	
Static Characteristic							
Drain-source breakdown voltage	BVpss	650	-	-	V	Vgs=0V, Ib=250uA	
Gate threshold voltage	VGS(th)	2	-	4	V	VDS=VGS,ID=7mA	
Zero gate voltage drain current	loss	-	1 10	100	μA	Vps=650V,Vgs=0V T _j =25°C T _j =175°C	
Gate-source leakage current	Igss	-		250	nA	Vgs=20V,Vps=0V	
		-	45	-		Vgs=18V, ID=17.6A,	
Drain-source on-state resistance	RDS(on)	-	33 50	49 -	m	Vgs=20V, Ib=17.6A, Tj=25°C Tj=175°C	
Transconductance	g fs	-	5.6	-	S	Vps=20V,Ip=17.6A	
Dynamic Characteristic	l .		I	1		•	
Input Capacitance	Ciss	-	1823	-		V _{DS} = 650V V _{GS} = 0V T _J = 25°C V _{AC} = 25mV f = 1MHz	
Output Capacitance	Coss	-	190	-	pF		
Reverse Transfer Capacitance	Crss	-	19	-			
Gate Total Charge	QG	-	96	-		V _{DS} = 400V V _{GS} = -5/20V I _D = 17.6A	
Gate-Source charge	Qgs	-	25	-	nC		
Gate-Drain charge	Qgd	-	26	-			
Turn-On Switching Energy	Еом	-	188	-	1	V _{DD} = 400V V _{GS} = -5/+20V I _D = 17.6A R _G = 10 L = 100uH	
Turn-Off Switching Energy-	Eoff	-	19		μJ		
Turn-on delay time	t _{d(on)}	-	20	-	20		
Rise time	tr	-	26	-			
Turn-off delay time	td(off)	-	48	-	ns		
Fall time	tf	-	15	-			
Gate resistance	Rg	-	1.7	-		Vac = 25mV, f=1MHz	



Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition	
i arameter	Symbol	min.	typ.	max.) iii	rest condition	
Body Diode Forward Voltage	Vsp		3.2		V	Vgs=0V,Isp=8.8A, TJ=25°C	
	VSD		2.6			Vgs=0V,Isb=8.8A, TJ=175°C	
Body Diode Reverse Recovery Time	trr	-	40	-	ns	VR = 400V, ID = 17.6A	
Body Diode Reverse Recovery Charge	Qrr	-	156	-	nC	di/dt = 1000A/μS	



Typical Performance Characteristics

Fig 1. Output Characteristic (T_J=-55°C)

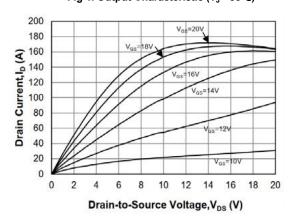


Fig 2. Output Characteristic (T_J=25°C)

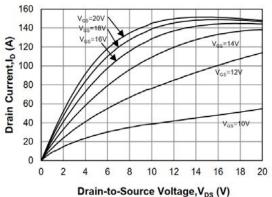


Fig 3. Output Characteristic (T_J=175℃)

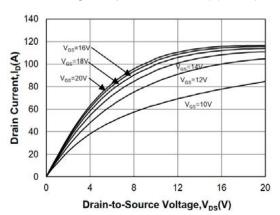


Fig 4: Rdson Vs Ids Characteristic

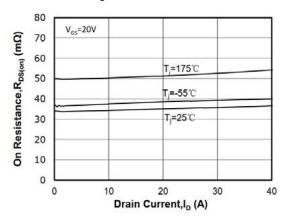


Fig 5: Rds(on) vs. Temperature

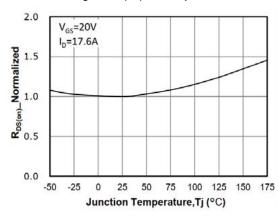
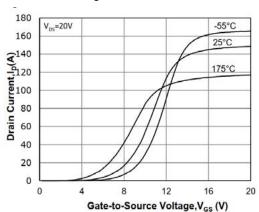
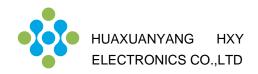
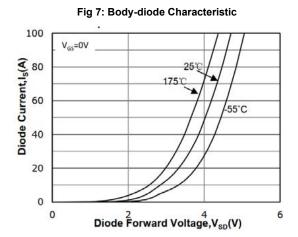
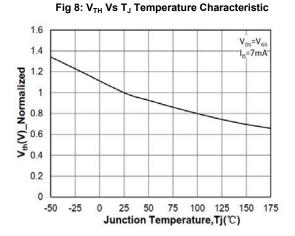


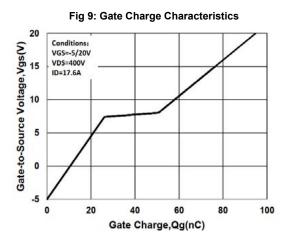
Fig 6: Transfer Characteristic

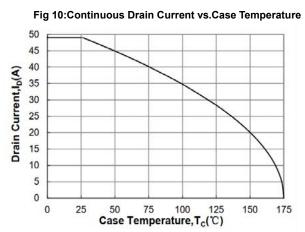


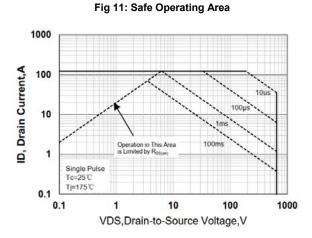


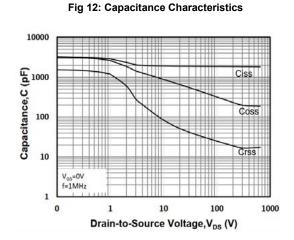






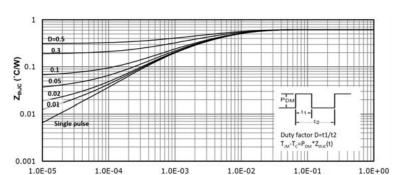






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tp (sec)

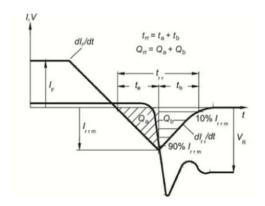
Fig 13: Transient Thermal Impedance

Test Circuit & Waveform

Figure A. Definition of switching times

Figure B. Dynamic test circuit

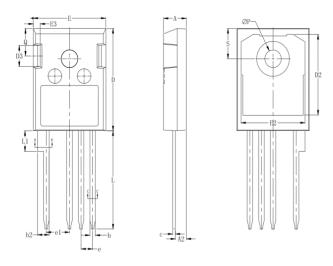
Figure C. Definition of body diodeswitching characteristics





Package Dimensions

Package TO-247-4L(TO-247-4)



Itomo	Values(mm)			
Items	MIN	MAX		
Α	4.8	5.2		
A2	2.2	2.6		
b	1.05	1.4		
b2	2.4	2.75		
С	0.5	0.75		
D	20	21.5		
D2	15.5	17.2		
D3	4	5		
E	15.5	16.1		
E2	13	15		
E3	1	2		
е	2.54 BSC.			
e1	5.08 BSC.			
L	19	21		
L1	4	4.45		
ФР	3.5	3.7		
Q	5.4	5.9		
S	5.9	6.4		

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